

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/807,205 GORIN ET AL.	
		Examiner	Art Unit	Page 1 of 1 Patrick J. Assouad 2857

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,335,615	01-2002	Gorin, Joseph M	324/76.39
	B	US-6,370,484	04-2002	Gorin et al.	702/66
	C	US-6,640,193	10-2003	Kuyel, Turker	702/69
	D	US-5,172,064	12-1992	Walls, Fred L.	324/601
	E	US-6,714,898	03-2004	Kapetanic et al.	702/191
	F	US-5,416,422	05-1995	Dildine, Robert G.	324/614
	G	US-6,621,277	09-2003	Mar, Wing Jong	324/622
	H	US-6,661,836	12-2003	Dalal et al.	375/226
	I	US-6,393,372	05-2002	Rzyski, Eugene	702/111
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	K	US-6,263,289	07-2001	Hassun et al.	702/69
	L	US-6,246,717	06-2001	Chen et al.	375/226
	M	US-6,701,265	03-2004	Hill et al.	702/91

FOREIGN PATENT DOCUMENTS

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	O					
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Agilent Technologies Internet Web Page entitled: "ESA-E Series Opt 226 Phase Noise Measurement", date unknown, 1 page.
	V	Agilent Technologies Product Overview entitled "Phase Noise Measurement Personality for the Agilent ESA-E Series Spectrum Analyzers", date unknown, 8 pages.
	W	Agilent Technologies Technical Overview entitled: Agilent ESA-E Series Spectrum Analyzers Noise Figure Measurements Personality", date unknown, 20 pages.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.